



## DESCRIPTION

The AM04N65 is available in TO220F Package.

## APPLICATION

- Adaptor
- Charger
- SMPS Standby Power

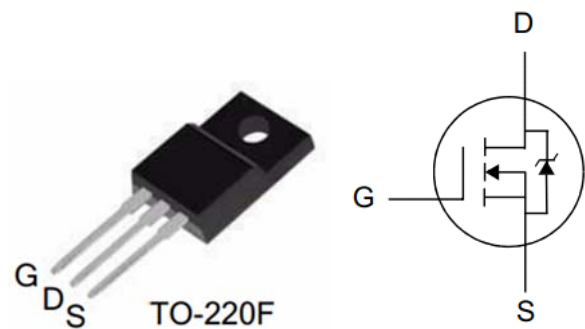
## FEATURE

- $R_{DS(ON),typ.} = 2.1 \Omega @ V_{GS} = 10V$
- High Current Rating
- Lower Capacitance
- Lower Total Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

## ORDERING INFORMATION

Package Type	Part Number	
TO220F SPQ:50pcs /Tube	T3F	AM04N65T3FU
		AM04N65T3FVU
Note	V: Halogen free Package U: Tube	
AiT provides all RoHS products		

## PIN DESCRIPTION



Pin#	Symbol	Function
1	G	Gate
2	D	Drain
3	S	Source



## ABSOLUTE MAXIMUM RATINGS

T<sub>A</sub> = 25°C, unless otherwise specified.

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	650	V
Gate-to-Source Voltage	V <sub>GSS</sub>	±30	
Continuous Drain Current	I <sub>D</sub>	4.0	A
Pulsed Drain Current at V <sub>GS</sub> =10V	I <sub>DM</sub>	16	
Single Pulse Avalanche Energy	E <sub>AS</sub>	250	mJ
Power Dissipation	P <sub>D</sub>	30	W
Derating Factor above 25°C		0.24	W/°C
Soldering Temperature Distance of 1.6mm from case for 10 seconds	T <sub>L</sub>	300	°C
Operating Temperature Range	T <sub>J</sub>	-55 to 150	°C
Storage Temperature Range	T <sub>STG</sub>	-55 to 150	°C
<b>THERMAL RESISTANCE</b>			
Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	R <sub>θJC</sub>	4.17	°C/W
Thermal Resistance, Junction-to-Ambient	R <sub>θJA</sub>	100	

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



**ELECTRICAL CHARACTERISTICS**

T<sub>A</sub> = 25°C, unless otherwise specified.

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	650			V
Drain-to-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V			1	uA
		V <sub>DS</sub> =520V, V <sub>GS</sub> =0V, T <sub>A</sub> =125°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =+20V, V <sub>DS</sub> =0V			+10	uA
		V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V			-10	
<b>ON CHARACTERISTICS</b>						
Static Drain-to-Source On-Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =2.0A		2.1	2.5	Ω
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	2.0		4.0	V
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> =15V, I <sub>D</sub> =2.0A		5.0		S
<b>Dynamic CHARACTERISTICS</b>						
Input Capacitance	C <sub>iSS</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz		450		pF
Reverse Transfer Capacitance	C <sub>rSS</sub>			6.0		
Output Capacitance	C <sub>oss</sub>			50		
Total Gate Charge	Q <sub>g</sub>	V <sub>DD</sub> =325V, I <sub>D</sub> =4A, V <sub>GS</sub> =0 to 10V		8.5		nC
Gate-to-Source Charge	Q <sub>gs</sub>			2.8		
Gate-to-Drain (Miller) Charge	Q <sub>gd</sub>			2.5		
<b>Resistive Switching CHARACTERISTICS</b>						
Turn-on Delay Time	t <sub>d(ON)</sub>	V <sub>DD</sub> =325V, I <sub>D</sub> =4A, V <sub>GS</sub> =10V R <sub>g</sub> =4.7Ω		9.0		nS
Rise Time	trise			7.0		
Turn-Off Delay Time	t <sub>d(OFF)</sub>			22		
Fall Time	t <sub>fall</sub>			9.0		
<b>Source-Drain Diode CHARACTERISTICS</b>						
Continuous Source Current *	I <sub>SD</sub>	Integral PN- diode in MOSFET			4.0	A
Pulsed Source Current *	I <sub>SM</sub>				16	
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =4A, V <sub>GS</sub> =0V			1.5	V
Reverse Recovery Time	t <sub>rr</sub>	V <sub>GS</sub> =0V I <sub>F</sub> = I <sub>S</sub> , di/dt=100A/μs		235		ns
Reverse Recovery Charge	Q <sub>rr</sub>				750	

\*Pulse width≤380μs; duty cycle≤2%.



## TYPICAL PERFORMANCE CHARACTERISTICS

Fig 1. Maximum Transient Thermal Impedance

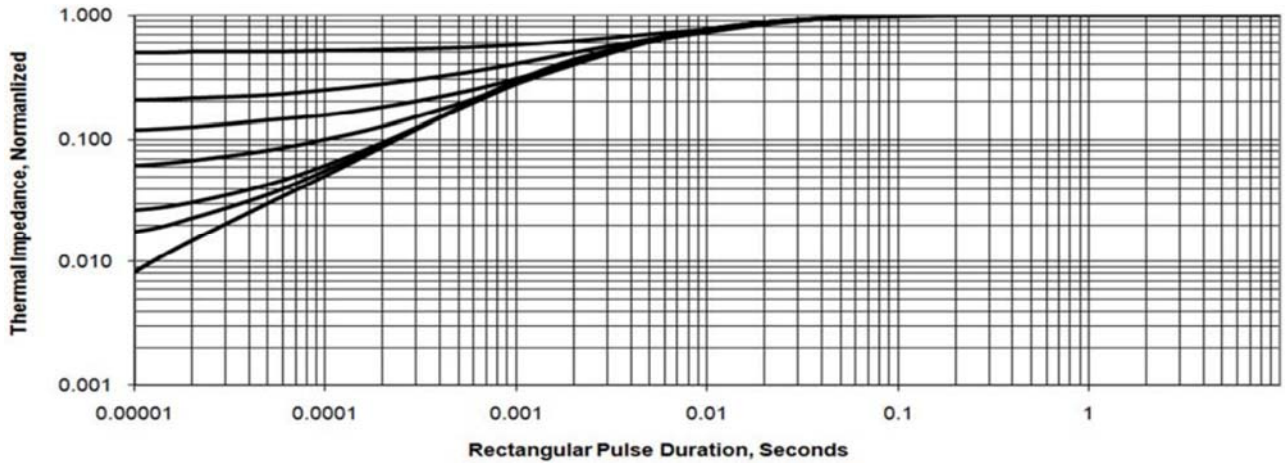


Fig 2. Maximum Power Dissipation vs Case Temperature

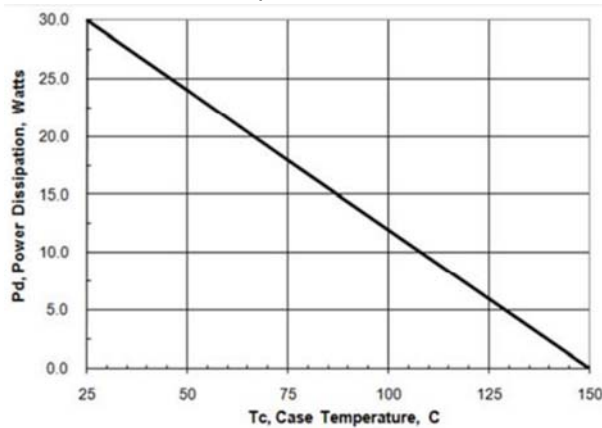


Fig 3. Maximum Continuous Drain Current vs Case Temperature

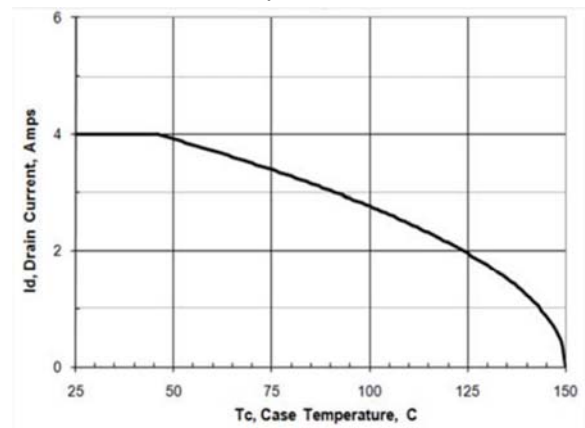


Fig 4. Typical Output Characteristics

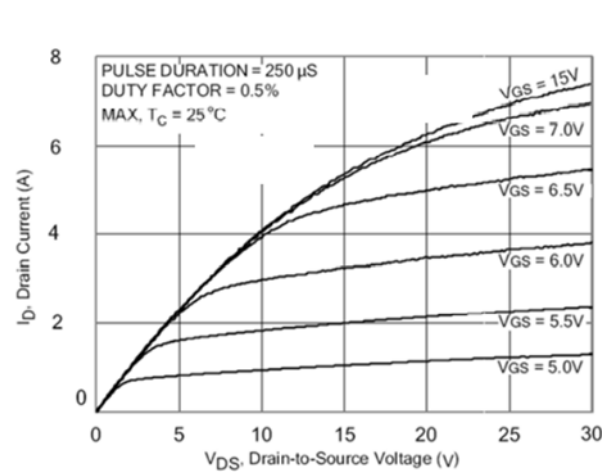


Fig 5. Typical Drain-to-Source ON Resistance Vs Gate Voltage and Drain Current

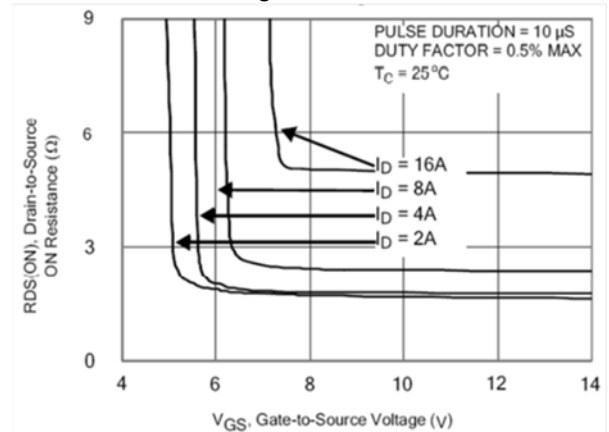




Fig 6. Maximum Peak Current Capability

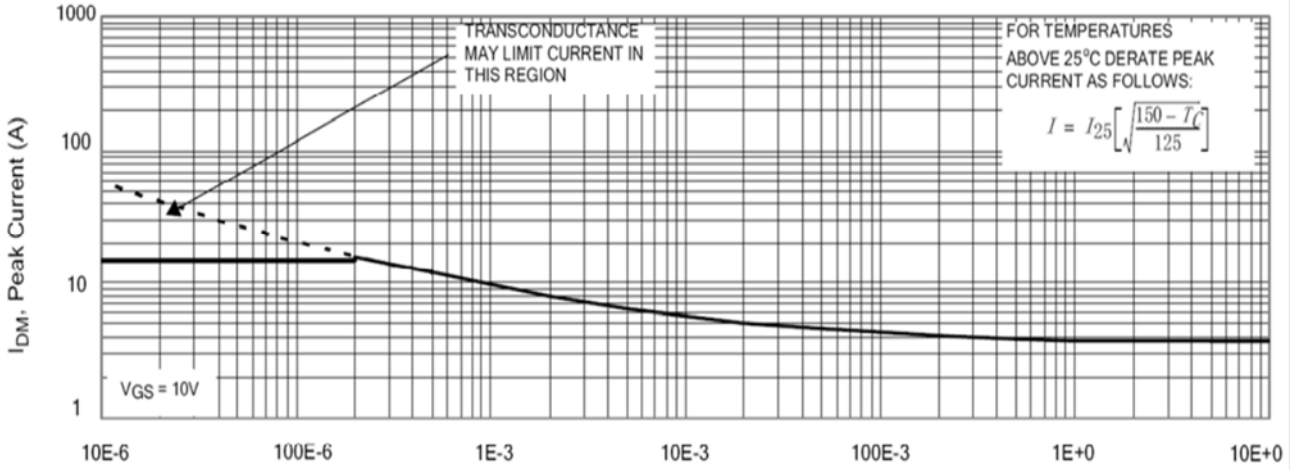


Fig 7. Typical Transfer Characteristics

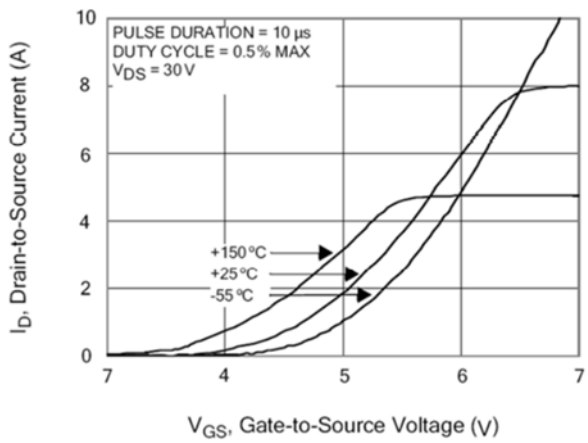


Fig 9. Typical Drain-to-Source ON Resistance vs Drain Current

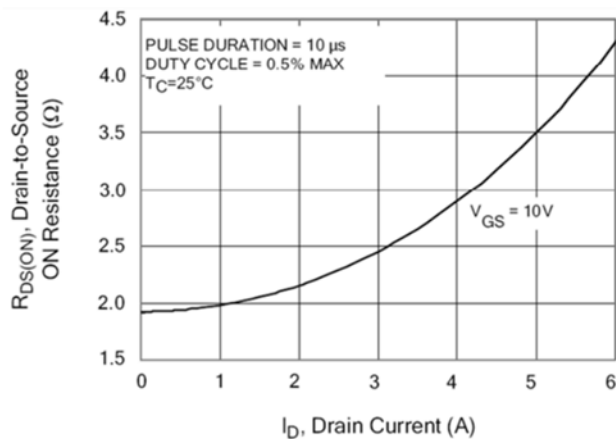


Fig 8. Unclamped Inductive Switching Capability

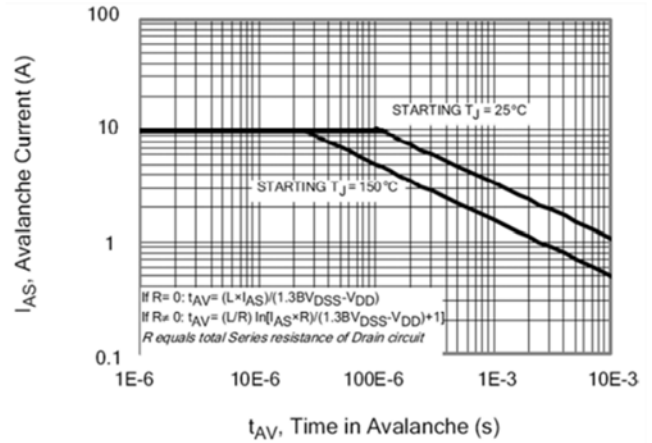


Fig 10. Typical Drain-to-Source ON Resistance vs Junction Temperature

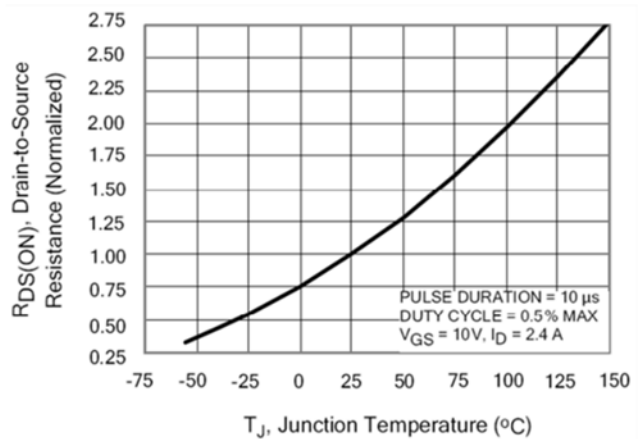




Fig11. Typical Breakdown Voltage vs Junction Temperature

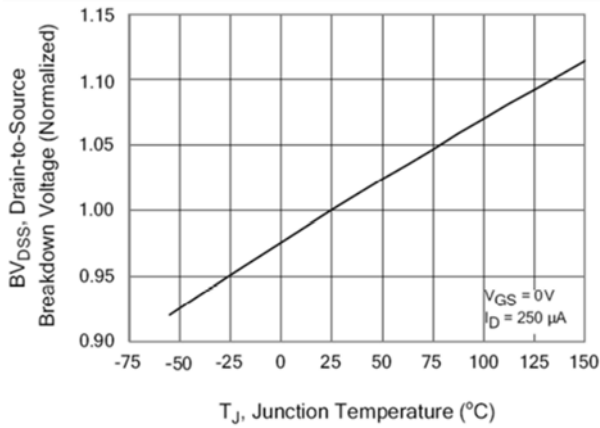


Fig 13. Maximum Safe Operating Area

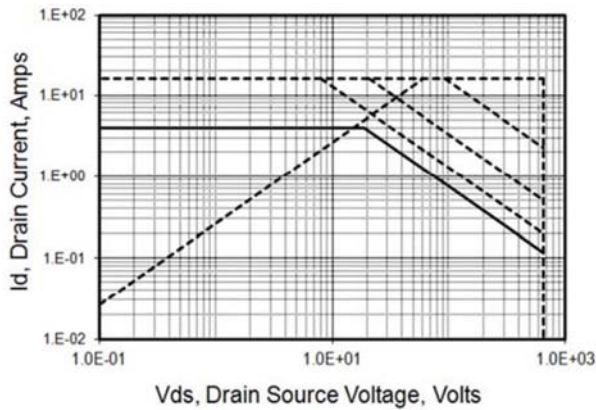


Fig 15. Typical Gate Charge

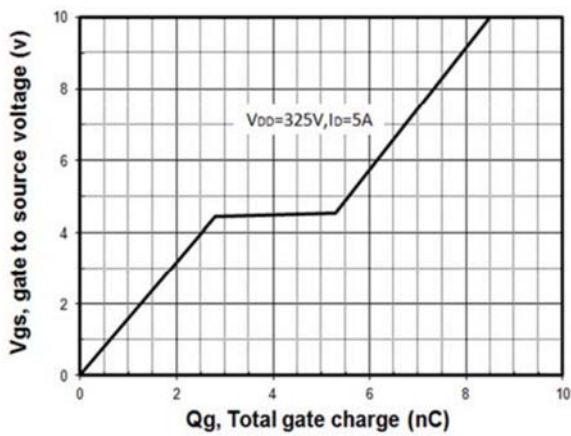


Fig 12. Typical Threshold Voltage vs Junction Temperature

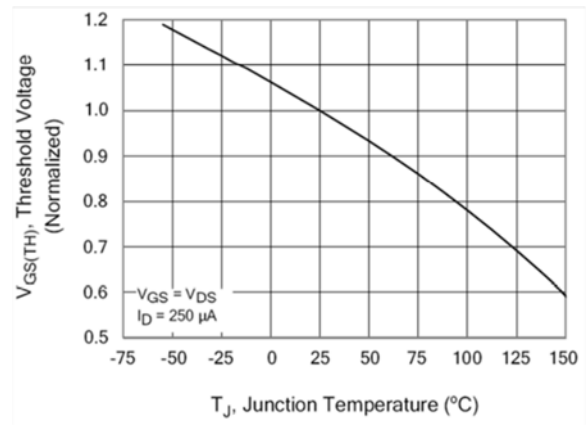


Fig 14. Typical Capacitance vs Drain-to-Source Voltage

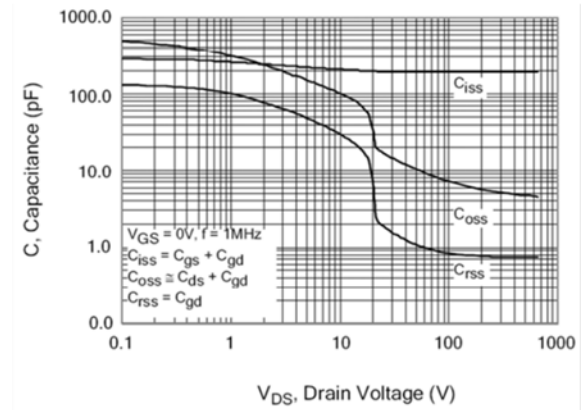
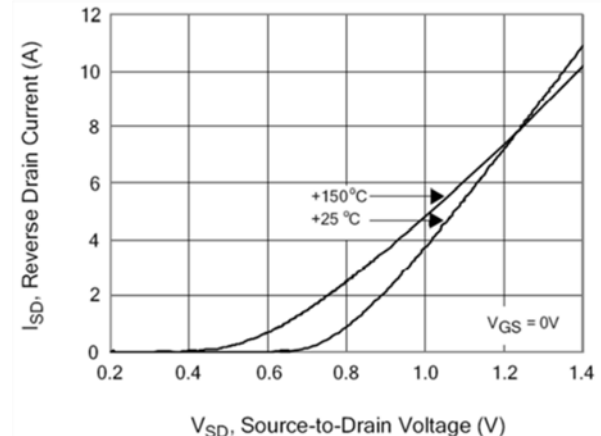


Fig 16. Typical Body Diode Transfer Characteristics





## TEST CIRCUITS AND WAVEFORMS

Fig. 17 Peak Diode Recovery dv/dt Test Circuit

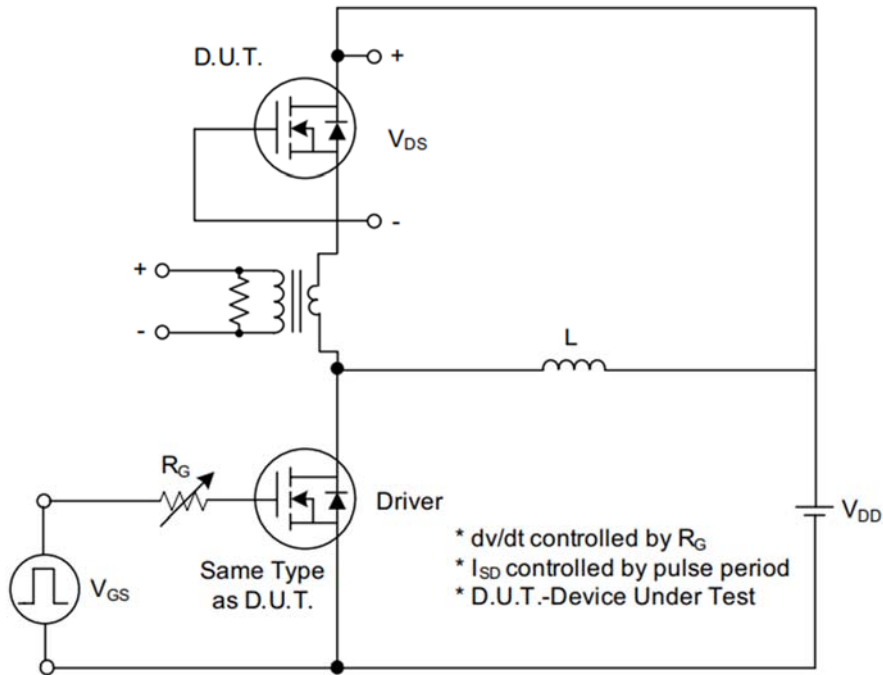


Fig. 18 Peak Diode Recovery dv/dt Waveforms

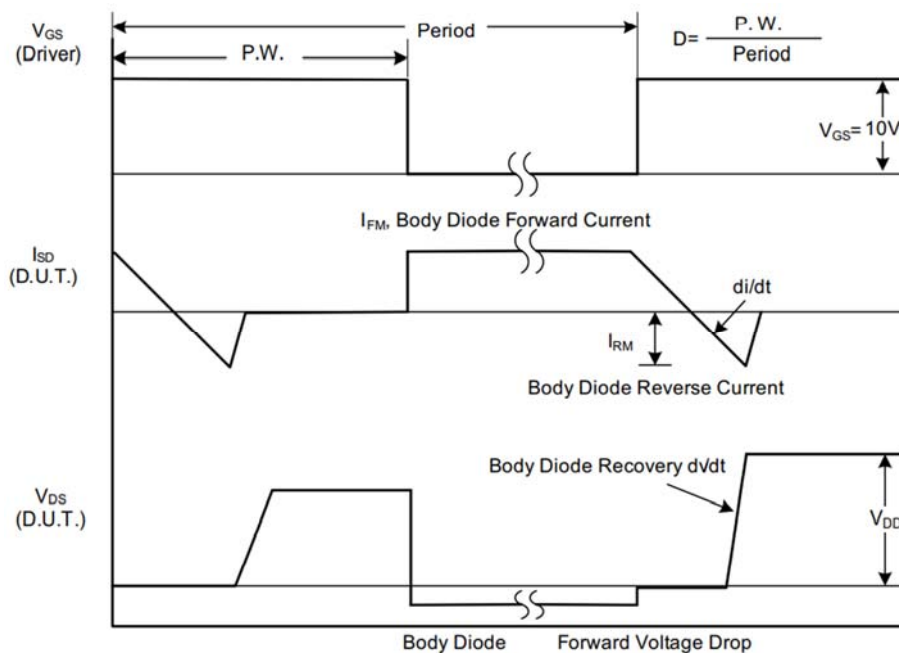




Fig 19. Switching Test Circuit

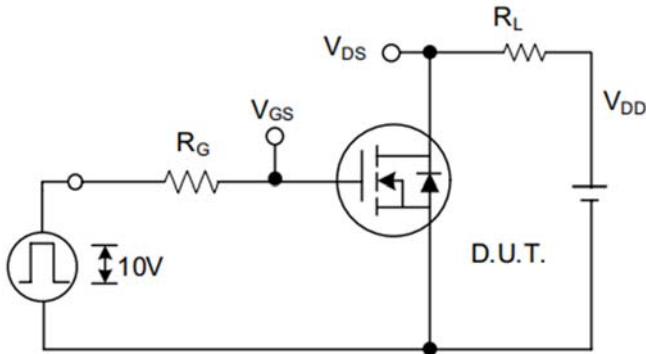


Fig 21. Gate Charge Test Circuit

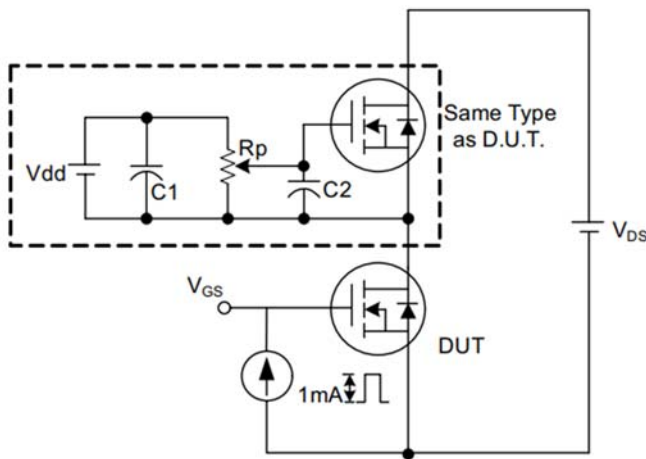


Fig 23. Unclamped Inductive Switching Test Circuit

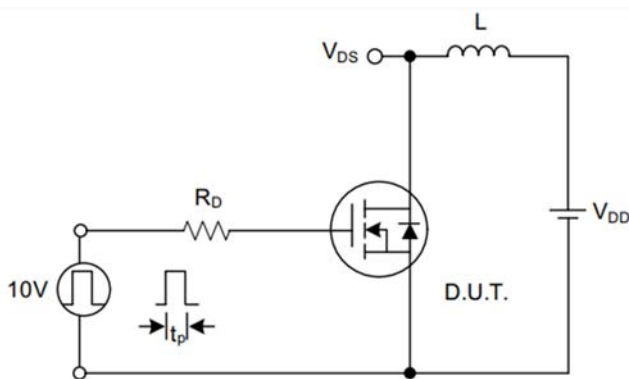


Fig 20. Switching Waveforms

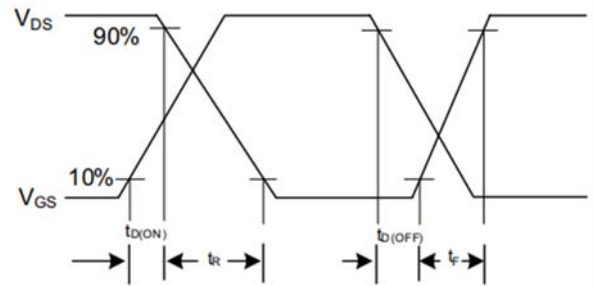


Fig 22. Gate Charge Waveform

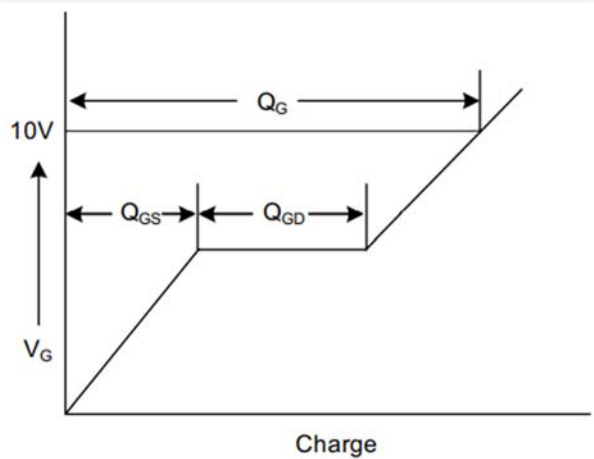
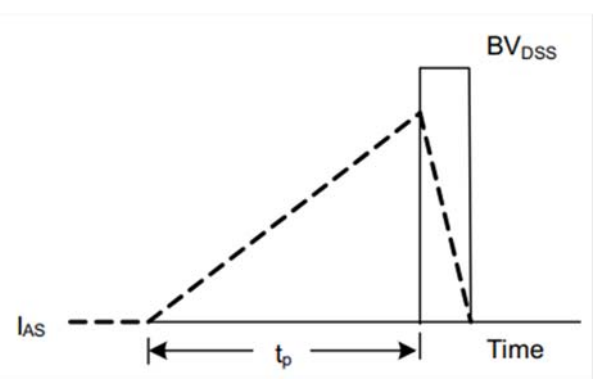


Fig 24. Unclamped Inductive Switching Waveforms

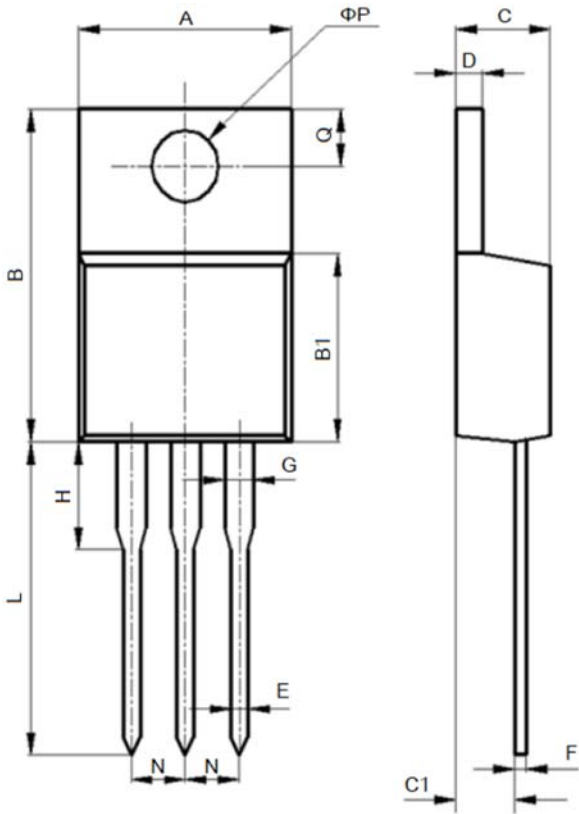






## PACKAGE INFORMATION

Dimension in TO-220F (Unit: mm)



Symbol	Min.	Max.
A	9.70	10.30
B	15.50	16.10
B1	8.99	9.39
C	4.40	4.80
C1	2.15	2.55
D	2.50	2.90
E	0.70	0.90
F	0.40	0.60
G	1.12	1.42
H	3.40	3.80
L	12.6	13.6
N	2.34	2.74
Q	3.15	3.55
ΦP	3.00	3.30



## IMPORTANT NOTICE

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